LAP15 Rec'd PCT/PTO 29 DEC 2005

8075-1024

IN THE U.S. PATENT AND TRADEMARK OFFICE

In re application of

Kuniyoshi YOKOH et al.

Conf.

Application No. NEW NATIONAL PHASE

Group

Filed December 29, 2005

Examiner

ELECTRON-EMITTING WOVEN FABRIC AND DISPLAY DEVICE USING SAME

INFORMATION DISCLOSURE STATEMENT (SUBMISSION CONCURRENT WITH THE FILING OF A NEW PATENT APPLICATION)

Assistant Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

December 29, 2005

Sir:

Pursuant to 37 C.F.R. §§ 1.97 and 1.98, and in fulfillment of the duty of disclosure under 37 C.F.R. § 1.56, applicant(s) hereby submit(s) an Information Disclosure Statement for consideration by the Examiner.

I. LIST OF PATENTS, PUBLICATIONS OR OTHER INFORMATION

The patents, publications, or other information submitted for consideration by the Office are listed on PTO-1449, attached hereto.

II. COPIES

- Copies of the U.S. patents or publications are not submitted since the USPTO has waived their submission for applications filed after June 30, 2003.
- Submitted herewith is a legible copy of (i) each foreign patent; (ii) each publication or that portion which caused it to be listed; and (iii) all other information or that portion which caused it to be listed.
- This application is a National Phase of a PCT application. Some or all of the documents listed on the PTO-1449 are not enclosed because they were cited in the International Search Report and copies should have been forwarded from the International Search Authority pursuant to the trilateral agreement between the USPTO, EPO and JPO, or they are U.S. patents or U.S. published applications. If copies are needed, please contact the undersigned.

Docket No. 8075-1024

III. CONCISE E (check at	EXPLANATION OF THE RELEVANCE P15 Rec'd PCT/PTO 29 DEC 2005
a. 🗌	DOCUMENTS IN THE ENGLISH LANGUAGE
	The attached non U.S. patents, non U.S. patent application publications, foreign publications, or other information in the English language do not require a statement of relevancy.
b. 🗌	DOCUMENTS NOT IN THE ENGLISH LANGUAGE
	A concise explanation of the relevance of all patents, publications, or other information listed that is not in the English language is as follows:
c. 🛛	FOREIGN SEARCH REPORT OR ACTION
	An English language version of the search report or action that indicates the degree of relevance found by the foreign office is attached, thereby satisfying the requirement for a concise explanation. See MPEP 609(A)(3).
d. □	OTHER
	The following additional information is provided for the Examiner's consideration.
	FEES
This Ir concurrently therefore, no	formation Disclosure Statement is being filed with the filing of a new patent application; fee is required.
If The E is requested t	xaminer has any questions concerning this IDS, he/she to contact the undersigned.
	Respectfully submitted,
	YOUNG & THOMPSON
	Benoît Castel
	Benoit Castel, Reg. No. 35,041 745 South 23 rd Street Arlington, VA 22202 Telephone (703) 521-2297 Telefax (703) 685-0573 (703) 979-4709
BC/yr	
Enclosures:	☑ Form PTO-1449(s)☐ Documents☑ Foreign Search Report
	Other:

INFOR	RMATION DISCLOSURE	Attorney Docket No.: 8075-1024		Application MC	ONAL PI	IASE	
	IN AN APPLICATION	Applicant: Kuniyoshi YOKOH et al.					
(Use several sheets if necessary)			Filing Date: December 29, 2005		Group Art Unit:		
		U.S. PATEN	NT DOCUMENTS				
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	11-302936	11/2/1999	JAPAN				
	2000-106101 2000-100358	4/11/2000 4/7/2000	JAPAN JAPAN				
	2000-100338	6/23/2000	JAPAN				-
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EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP § 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to the applicant.

^{*} English language abstract provided for the Examiner's convenience